

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Mehrdad Nikoonahad et al.

Title: Optical System For Measuring Samples Using Short Wavelength Radiation

Application No.: 10/718,126 Filing Date: November 19, 2003

Examiner: Pham, Hoa Q. Group Art Unit: 2886

Docket No.: TNCR.197US1 Conf. No.: 9108

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

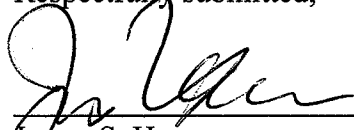
PETITION FOR EXTENSION OF TIME

Dear Sir:

Applicants respectfully petition for a one-month extension of time within which to respond to the April 18, 2007, outstanding Office Action, such extension allowing the undersigned until September 18, 2007, to respond. The fee of \$450.00 has been authorized via EFS to Deposit Account 04-0258. The Commissioner is hereby authorized to charge any additional fees, which may be required, or credit any overpayment to Deposit Account 04-0258.

FILED VIA EFS

Respectfully submitted,


James S. Hsue
Reg. No. 29, 545

09/18/2007

Date

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